

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination COHEN ET AL.	
		09/886,437	Examiner	Art Unit
		Zeev Kitov	2836	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,159,259	06-1979	Yajima et al.	528/14
	B	US-6,163,055	12-2000	Hirakata et al.	257/347
	C	US-5,153,554	10-1992	Becker et al.	338/21
	D	US-5,166,859	11-1992	Ueno et al.	361/321
	E	US-3,859,568	01-1975	Sakshaug	317/68
	F	US-4,809,044	02-1989	Pryor et al.	357/2
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	F. Zandman, P. Simon, Resistor Theory and Technology, 11/20/00, SciTech Publishing, Inc., pp. 247 - 254.
	V	Application Note AN9307, 07/1999, Harris Co., pp. 10-29 - 10-35.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.